

# LiNbO<sub>3</sub> composite oscillator for internal friction and modulus measurement at elevated temperatures

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We describe a longitudinal LiNbO<sub>3</sub> composite oscillator at 100–300 kHz to measure internal friction and Young's modulus of a small sample bar, which is directly heated in a furnace at elevated temperatures up to 800 °C. Resonant frequency, mechanical loss, and electric conductivity of a fabricated LiNbO<sub>3</sub> oscillator are measured as a function of temperature. The present method is successfully applied to YBa<sub>2</sub>Cu<sub>3</sub>O<sub>6+x</sub> wires with 1 mm diameter and 7 mm length at 30–800 °C.

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Internal friction and elastic modulus anomaly are a sensitive probe of the motion of defects in solids. Specifically, they are useful for electrically conductive crystals which cannot be applied by dielectric loss measurement. Many methods have been used, and the choice is dictated by the desired temperature and frequency range of the measurement. The piezoelectric composite oscillator method using a composite bar of a quartz crystal and a specimen bar is one of the useful techniques for elastic measurement at 30–300 kHz. In its original form,<sup>1–5</sup> the specimen was excited into vibration at the resonant frequency by cementing it to one end of a quartz. A quartz crystal is used as a detector as well as the excitation of vibration of the composite bar. The modification of this method has been reported by Marx<sup>6</sup> and Robinson<sup>7</sup> in order to improve the accuracy of the measurement for internal friction in low-amplitude range. The advantages of a one-crystal technique using a quartz in a cryostat was described by Schwarz.<sup>8</sup> The technique using a simple composite bar is in practice very useful for the elastic measurement of a small specimen such as 5–10 mm length and 1–3 mm<sup>2</sup> cross-section area, achieved by less expensive apparatus. We applied this method to the study of the relaxation behavior of oxygen vacancy in single-crystal and polycrystalline ZrO<sub>2</sub>–Y<sub>2</sub>O<sub>3</sub> at moderate temperatures of 100–500 °C.<sup>9,10</sup> However, a measurement technique using a quartz crystal was limited by low and moderate temperature ranges, because a quartz oscillator loses the piezoelectricity above the phase transition of 573 °C. A multicomponent system with a buffer rod to avoid heat influence on an oscillator often need a complex ailment for a sample/oscillator composite, because of a large variation of modulus and internal friction in wide temperature range. Also, the homogeneous heat environment for a sample and an oscillator is not achieved in these measurements.

The system that we describe in this work is a simple one-crystal composite oscillator using a lithium niobate (LiNbO<sub>3</sub>) crystal for high-temperature measurement. LiNbO<sub>3</sub> is a ferroelectric crystal of point group  $R_{3c}$  and transforms to paraelectric phase above 1210 °C. There has been literature on piezoelectric, elastic properties of LiNbO<sub>3</sub>, and its application as a resonator.<sup>11–14</sup> For the measurement of Young's modulus, we need an oscillator with longitudinal mode in modified cube axes. In a practical procedure to make a resonator, we employed commercially available LiNbO<sub>3</sub> crystal wafers for surface acoustic wave (SAW) device application

(Yamaju Ceramics, Japan). The piezoelectric-grade wafers were 1 or 2 mm thickness of 128° rotated-*Y* cut for a SAW filter in the MHz band. We fabricated a (*YXl*) 128° crystal oscillator with longitudinal vibration mode at frequencies of 200–300 kHz, whose dimension is 8–12 mm length and 1×2 mm cross section. The piezoelectric *d* matrix in the modified axes at room temperature was calculated using data in Refs. 11–14. Under an applied voltage to both faces of a present wafer normal to the modified *y* axis, the modified *x* direction along a long direction of a bar was proper in order to obtain pure longitudinal strain. The modified *d* value was calculated to  $d_{21} = -1.34 \times 10^{-11}$  C/N. If one takes a strain  $S_3$  (*z* axis), then  $S_4 \neq 0$ , so both longitudinal and stretching vibration are excited. The electrodes were coated with a platinum ink (Engelhard, NJ) followed by sintering–bonding of platinum wires at center positions on both surfaces of bars at 850–900 °C under a certain temperature schedule. The oscillators fabricated were further annealed at 900 °C for 30 min in air. The composite oscillator assembly in this work is illustrated as in Fig. 1.

The system to evaluate the resonance of both LiNbO<sub>3</sub> itself and a composite bar with a specimen consisted of an impedance analyzer (Hewlett Packard, HP 4192A), a personal computer with IEEE-488 interface (NEC-PC-9801, Japan), and a homemade electric furnace. The measurement procedure was the same as the evaluation of a piezoelectric resonator. 300 point sets of absolute admittance, phase shift, and applied frequency were recorded at resonance. A resonant frequency was graphically obtained from a plot of an admittance circle in a complex plane by the same manner as applied to an usual resonator. Figure 2 shows the plots of resonant frequency and mechanical loss versus temperature for longitudinal 200 kHz LiNbO<sub>3</sub> oscillator. There appeared to be a large loss peak and corresponding small nonlinear variation of the resonant frequency versus temperature at around 690 °C. There has rarely been a reference on such relaxation phenomenon to induce a large anelastic loss peak for LiNbO<sub>3</sub> at present temperature range. The influence of repeated heat treatment was not found on this peak. It is difficult to determine the origin of this relaxation in the present study, however we assume that it is due to a relaxation of a lithium ion or defect in a LiNbO<sub>3</sub> crystal. The dc conductivity of a LiNbO<sub>3</sub> longitudinal oscillator was also measured by a dc impedance from a circle in a Cole–Cole plot at various temperatures of 400–850 °C. The relation be-

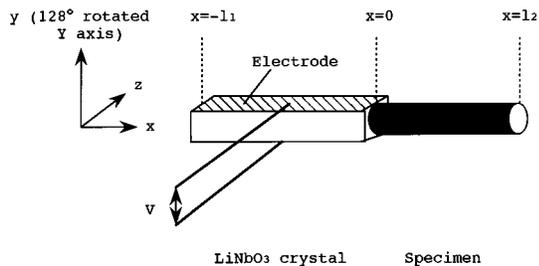


FIG. 1. LiNbO<sub>3</sub> composite oscillator.

tween  $\sigma$  and  $T$  was represented by an usual equation,  $\sigma = \sigma_0 \exp(-H/RT)$ , where  $\sigma_0 = 6.71 \times 10^3$  S/m, and an activation enthalpy  $H = 1.24$  eV.

Mathematic analysis of the piezoelectric resonance of a composite oscillator has been given by Read.<sup>5</sup> We used a technique of a one-crystal composite oscillator of a LiNbO<sub>3</sub> and a specimen in the measurement under a homogeneous heat environment at elevated temperature. The measured data for mechanical loss need be calibrated in order to reduce the damping of a used oscillator by the following equation:

$$Q_0^{-1} = (m_1 Q_1^{-1} + m_2 Q_2^{-1}) / (m_1 + m_2), \quad (1)$$

where  $Q_1^{-1}$ ,  $Q_2^{-1}$ , and  $Q_0^{-1}$  are mechanical loss (internal friction) of a resonator, sample, and composite bar, respectively. Solving the longitudinal wave equation for the system with the appropriate boundary conditions at  $x = -l_1$  and  $x = l_2$ , using the continuity of the displacement and of the axial force at  $x = 0$ , one finds a relation between the resonant frequency  $f_0$  of a composite oscillator, the free resonance  $f_1$  of the piezoelectric crystal driver and  $f_2$  of the specimen, and their respective masses  $m_1$  and  $m_2$ ,

$$m_1 f_1 \tan(\pi f_0 / f_1) + m_2 f_2 \tan(\pi f_0 / f_2) = 0. \quad (2)$$

Since the elastic constants of a oscillator crystal and a sample vary differently with temperature, a true match between  $f_1$  and  $f_2$  cannot be maintained over the temperature range of 30–800 °C. In order to minimize to mismatches between  $f_1$  and  $f_2$ ,  $m_1 = m_2$  is desirable, as described by Schwarz.<sup>8</sup> However, this mismatch is indispensable to the composite-oscillator method applied in the wide range of temperature.

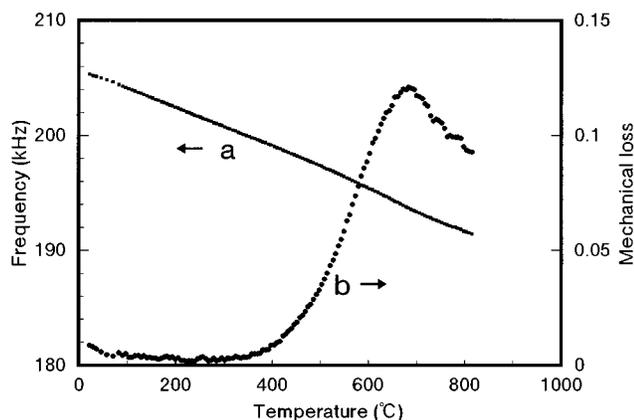


FIG. 2. Plots of (a) resonant frequency and (b) mechanical loss of a longitudinal 200 kHz LiNbO<sub>3</sub> oscillator vs temperature.

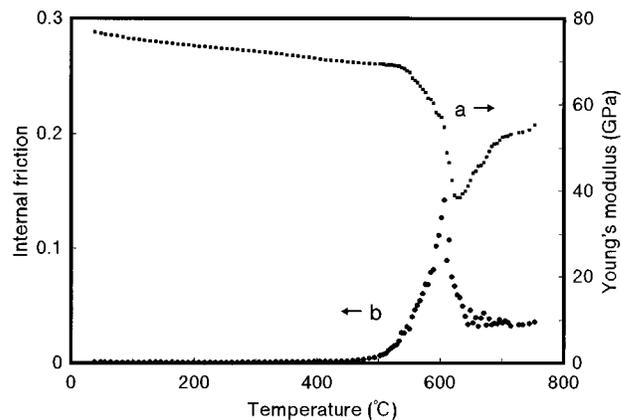


FIG. 3. Temperature dependence of (a) Young's modulus and (b) internal friction of YBa<sub>2</sub>Cu<sub>3</sub>O<sub>6+x</sub> wire annealed in flowing oxygen at 550 °C.

Kudo and Ozawa have proposed simple experimental equations to calibrate internal friction and  $f_0$  measured using several oscillators having different resonant frequencies.<sup>15</sup>

Figure 3 shows an example measured using the present LiNbO<sub>3</sub> composite-oscillator technique at 200 kHz under directly heated environment in the furnace. Young's modulus and internal friction of YBa<sub>2</sub>Cu<sub>3</sub>O<sub>6+x</sub> annealed in flowing oxygen at 550 °C for 15 h are illustrated as a function of temperature up to 800 °C. The data were calibrated by Eq. (1) and experimental curves for correction.<sup>15</sup> Anelastic relaxation measurements for YBa<sub>2</sub>Cu<sub>3</sub>O<sub>6+x</sub> above room temperature have been carried out by several methods<sup>16,18–20</sup> as well as Marx's technique using a quartz and a buffer material.<sup>17,21</sup> It has been assumed that an internal friction peak above room temperature is due to the movement of oxygen defect between O1 and O5 sites in orthorhombic YBa<sub>2</sub>Cu<sub>3</sub>O<sub>6+x</sub>. In Fig. 3, there is observed an internal friction peak at 590 °C, indicating relaxation of oxygen vacancy, and an anomaly of modulus due to the orthorhombic-to-tetragonal phase transition at around 633 °C.

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